

این دیتاشیت توسط توکل الکترونیک تهیه و ارائه شده است.
جهت مشاهده قیمت، موجودی و ثبت سفارش این قطعه به وبسایت توکل الکترونیک مراجعه فرمایید.



مشاهده قیمت و خرید
برای خرید و مشاهده سایر محصولات کلیک کنید



STS4C3F60L

N-CHANNEL 60V - 0.045 Ω - 4A SO-8

P-CHANNEL 60V - 0.100 Ω - 3A SO-8

StripFET™ MOSFET

Table 1: General Features

TYPE	V _{DSS}	R _{DS(on)}	I _D
STS4C3F60L (N-Channel)	60 V	< 0.055 Ω	4 A
STS4C3F60L (P-Channel)	60 V	< 0.120 Ω	3 A

- TYPICAL R_{DS(on)} (N-Channel) = 0.045 Ω
- TYPICAL R_{DS(on)} (P-Channel) = 0.100 Ω
- STANDARD OUTLINE FOR EASY AUTOMATED SURFACE MOUNT ASSEMBLY
- LOW THRESHOLD DRIVE

DESCRIPTION

This MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

APPLICATIONS

- DC/DC CONVERTERS
- BACK LIGHT INVERTER FOR LCD

Figure 1: Package

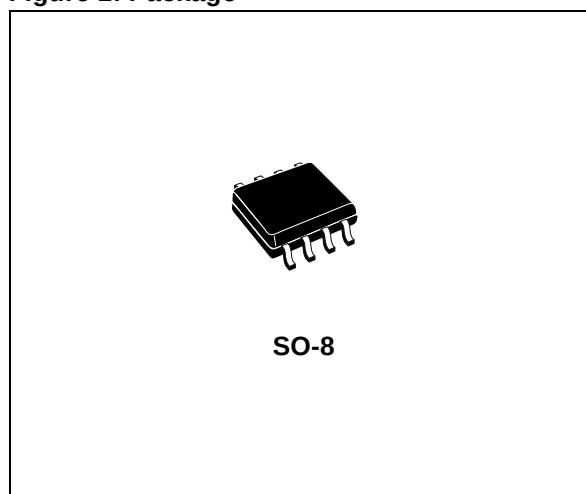


Figure 2: Internal Schematic Diagram

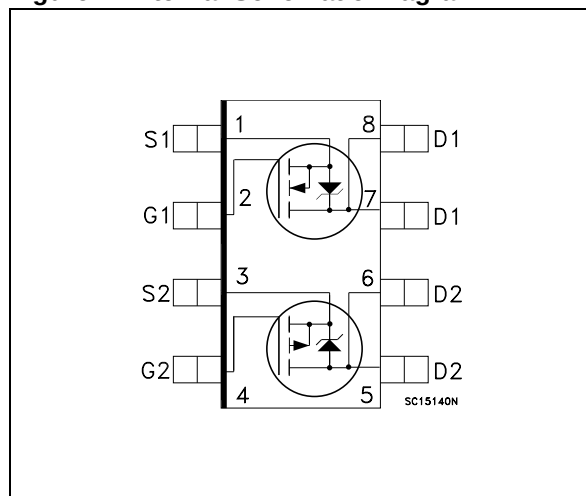


Table 2: Order Codes

PART NUMBER	MARKING	PACKAGE	PACKAGING
STS4C3F60L	S4C3F60L	SO-8	TAPE & REEL

Table 3: Absolute Maximum ratings

Symbol	Parameter	Value		Unit
		N-CHANNEL	P-CHANNEL	
V_{DS}	Drain-source Voltage ($V_{GS} = 0$)	60		V
V_{DGR}	Drain-gate Voltage ($R_{GS} = 20\text{ k}\Omega$)	60		V
V_{GS}	Gate-source Voltage	± 16		V
I_D	Drain Current (continuous) at $T_C = 25^\circ\text{C}$ Single Operating	4	3	A
I_D	Drain Current (continuous) at $T_C = 100^\circ\text{C}$ Single Operating	2.5	1.9	A
$I_{DM}(\bullet)$	Drain Current (pulsed)	16	12	A
P_{TOT}	Total Dissipation at $T_C = 25^\circ\text{C}$	2		W
T_j T_{stg}	Operating Junction Temperature Storage Temperature	-55 to 150		$^\circ\text{C}$

($\bullet$) Pulse width limited by safe operating area

Note: For the P-CHANNEL MOSFET actual polarity of voltages and current has to be reversed

Table 4: Thermal Data

Rthj-amb (1)	Thermal Resistance Junction-ambient	62.5	$^\circ\text{C/W}$
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(1) When mounted on 1 inch² pad of 2 oz. copper, $t \leq 10\text{ s}$

ELECTRICAL CHARACTERISTICS ($T_{CASE} = 25^\circ\text{C}$ UNLESS OTHERWISE SPECIFIED)

Table 5: On/Off

Symbol	Parameter	Test Conditions		Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source Breakdown Voltage	$I_D = 250\text{ }\mu\text{A}$, $V_{GS} = 0$	n-ch p-ch	60 60			V V
I_{DSS}	Zero Gate Voltage Drain Current ($V_{GS} = 0$)	$V_{DS} = \text{Max Rating}$ $V_{DS} = \text{Max Rating}$, $T_C = 125^\circ\text{C}$	n-ch p-ch			1 10	μA μA
I_{GSS}	Gate-body Leakage Current ($V_{DS} = 0$)	$V_{GS} = \pm 16\text{V}$ $V_{GS} = \pm 16\text{V}$	n-ch p-ch			± 100 ± 100	nA nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$	n-ch p-ch	1 1.5			V V
$R_{DS(on)}$	Static Drain-source On Resistance	$V_{GS} = 10\text{ V}$, $I_D = 2\text{ A}$ $V_{GS} = 10\text{ V}$, $I_D = 1.5\text{ A}$ $V_{GS} = 4.5\text{ V}$, $I_D = 2\text{ A}$ $V_{GS} = 4.5\text{ V}$, $I_D = 1.5\text{ A}$	n-ch p-ch n-ch p-ch		0.045 0.100 0.050 0.130	0.055 0.120 0.065 0.160	Ω Ω Ω Ω

Table 6: Dynamic

Symbol	Parameter	Test Conditions		Min.	Typ.	Max.	Unit
$g_{fs}(1)$	Forward Transconductance	$V_{DS} = 30\text{ V}$, $I_D = 2\text{ A}$ $V_{DS} = 10\text{ V}$, $I_D = 3\text{ A}$	n-ch p-ch		7 7.2		S S
C_{iss}	Input Capacitance	$V_{DS} = 25\text{V}$, $f = 1\text{ MHz}$, $V_{GS} = 0$	n-ch p-ch		1030 630		pF pF
C_{oss}	Output Capacitance		n-ch p-ch		140 121		pF pF
C_{rss}	Reverse Transfer Capacitance		n-ch p-ch		40 49		pF pF

(1) Pulsed: Pulse duration = 300 μs , duty cycle 1.5%

ELECTRICAL CHARACTERISTICS (CONTINUED)

Table 7: Switching On

Symbol	Parameter	Test Conditions		Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on Delay Time	N-CHANNEL $V_{DD} = 30\text{ V}$, $I_D = 2\text{ A}$, $R_G = 4.7\ \Omega$, $V_{GS} = 4.5\text{ V}$	n-ch p-ch		15 124		ns ns
t_r	Rise Time	P-CHANNEL $V_{DD} = 30\text{ V}$, $I_D = 1.5\text{ A}$, $R_G = 4.7\ \Omega$, $V_{GS} = 4.5\text{ V}$ (Resistive Load see, Figure 28)	n-ch p-ch		28 54		ns ns
Q_g	Total Gate Charge	N-CHANNEL $V_{DD} = 48\text{ V}$, $I_D = 4\text{ A}$, $V_{GS} = 4.5\text{ V}$	n-ch p-ch		15 11.6	20.4 15.7	nC nC
Q_{gs}	Gate-Source Charge	P-CHANNEL $V_{DD} = 48\text{ V}$, $I_D = 3\text{ A}$, $V_{GS} = 4.5\text{ V}$	n-ch p-ch		4 4.5		nC nC
Q_{gd}	Gate-Drain Charge	$V_{GS} = 4.5\text{ V}$ (see, Figure 31)	n-ch p-ch		4 4.7		nC nC

Table 8: Switching Off

Symbol	Parameter	Test Conditions		Min.	Typ.	Max.	Unit
$t_{d(off)}$	Turn-off Delay Time	N-CHANNEL $V_{DD} = 30\text{ V}$, $I_D = 2\text{ A}$, $R_G = 4.7\ \Omega$, $V_{GS} = 4.5\text{ V}$	n-ch p-ch		45 39		ns ns
t_f	Fall Time	P-CHANNEL $V_{DD} = 30\text{ V}$, $I_D = 1.5\text{ A}$, $R_G = 4.7\ \Omega$, $V_{GS} = 4.5\text{ V}$ (Resistive Load see, Figure 28)	n-ch p-ch		10 14.5		ns ns

Table 9: Source-Drain Diodef

Symbol	Parameter	Test Conditions		Min.	Typ.	Max.	Unit
I_{SD}	Source-drain Current		n-ch p-ch			4 3	A A
$I_{SDM(2)}$	Source-drain Current (pulsed)		n-ch p-ch			16 12	A A
$V_{SD(1)}$	Forward On Voltage	$I_{SD} = 4\text{ A}$, $V_{GS} = 0$ $I_{SD} = 3\text{ A}$, $V_{GS} = 0$	n-ch p-ch			1.2 1.2	V V
t_{rr}	Reverse Recovery Time	N-CHANNEL $I_{SD} = 4\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$ $V_{DD} = 20\text{ V}$, $T_j = 150^\circ\text{C}$	n-ch p-ch		85 44		ns ns
Q_{rr}	Reverse Recovery Charge		n-ch p-ch		85 68.2		nC nC
I_{RRM}	Reverse Recovery Current	P-CHANNEL $I_{SD} = 3\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$ $V_{DD} = 20\text{ V}$, $T_j = 150^\circ\text{C}$ (see test circuit, Figure 29)	n-ch p-ch		2 3.1		A A

(1) Pulsed: Pulse duration = 300 μs , duty cycle 1.5 %.

(2) Pulse width limited by safe operating area.

Figure 3: .Safe Operating n-channel

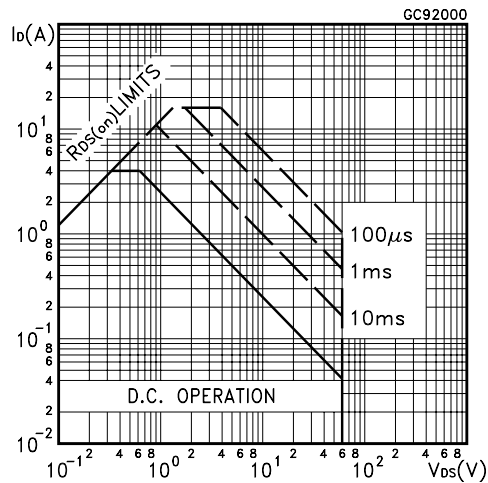


Figure 4: Output Characteristics n-channel

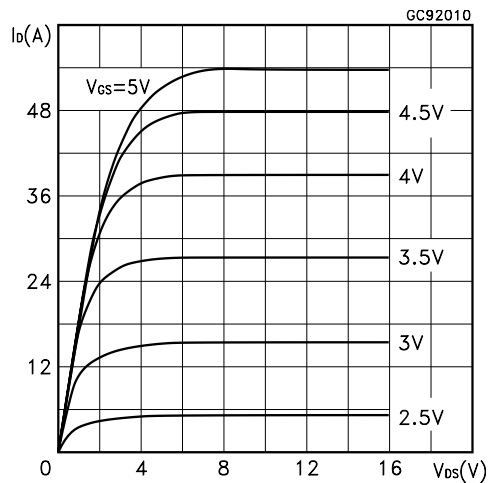


Figure 5: Transconductance n-channel

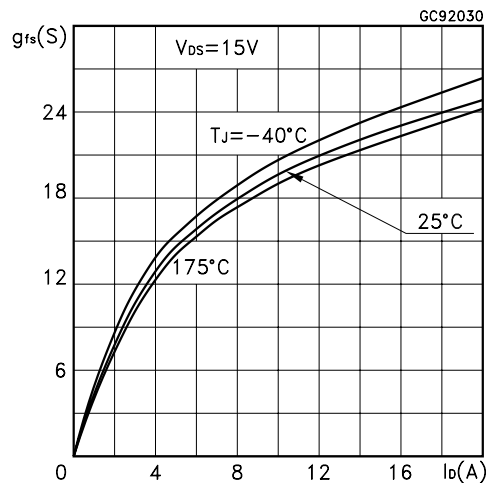


Figure 6: Thermal Impedance For Complementary Pair

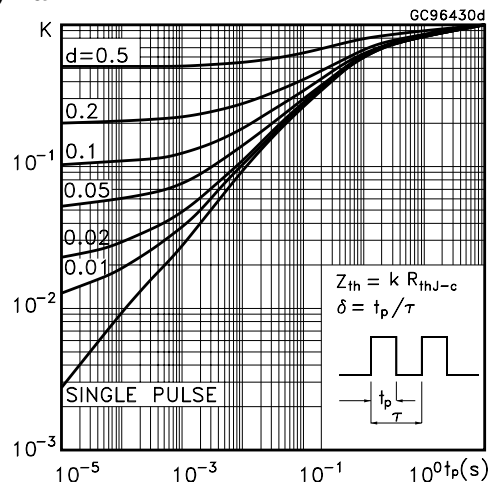


Figure 7: Transfer Characteristics n-channel

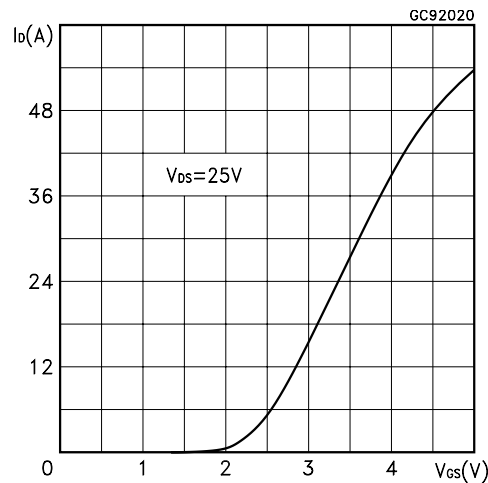


Figure 8: Static Drain-Source On Resistance n-channel

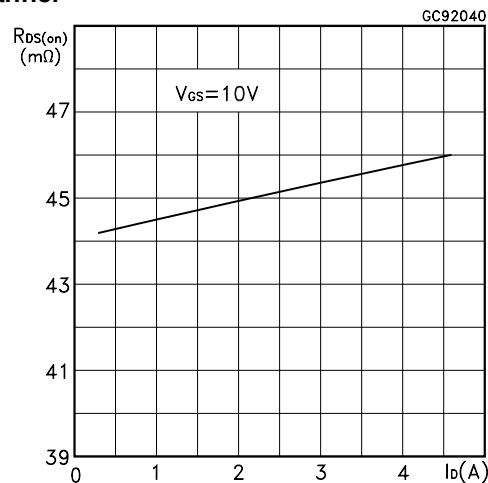


Figure 9: Gate Charge vs Gate-Source Voltage n-channel

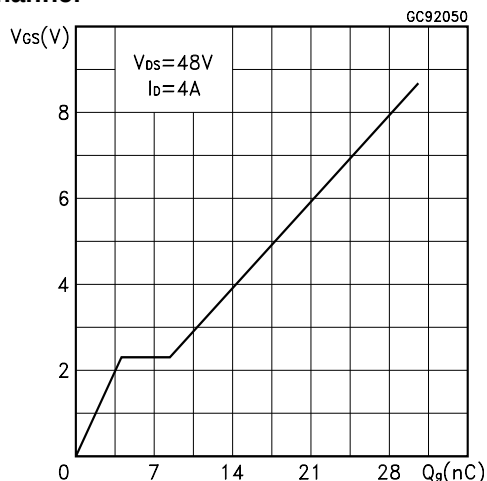


Figure 10: Normalized Gate Threshold Voltage vs Temperature n-channel

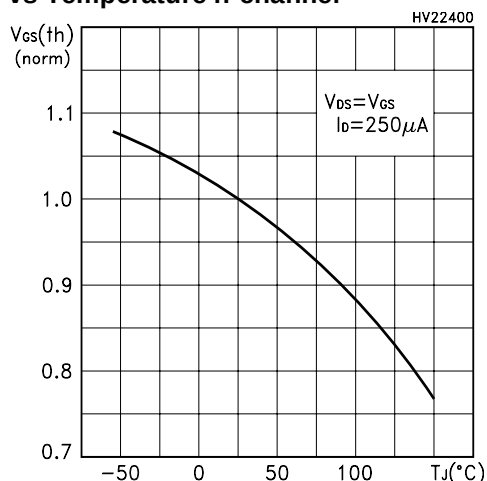


Figure 11: Source-Drain Forward Characteristics n-channel

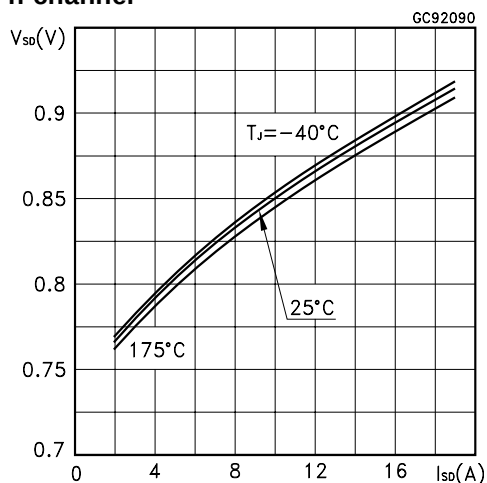


Figure 12: Capacitance Variations n-channel

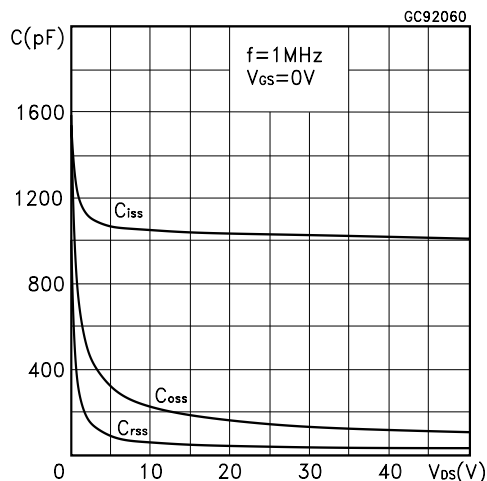


Figure 13: Normalized On Resistance vs Temperature n-channel

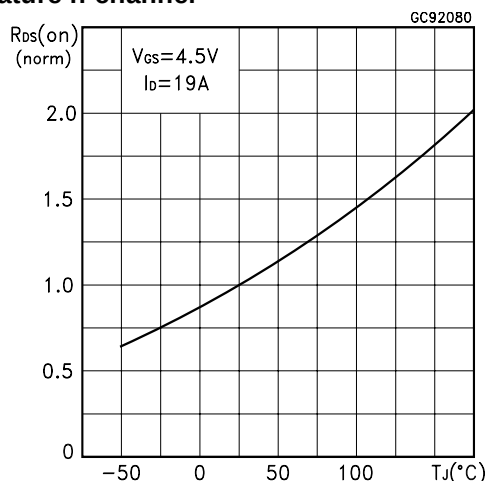


Figure 14: Normalized BVdss vs Temperature n-channel

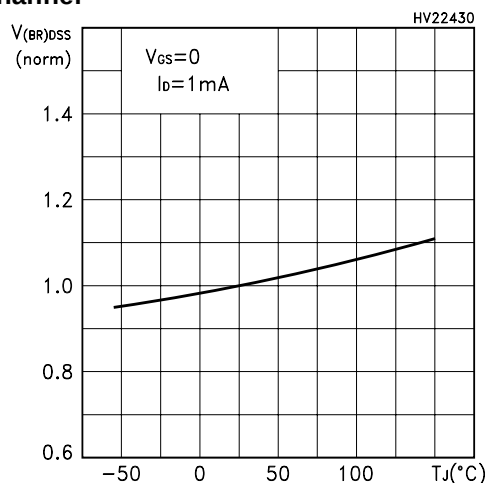


Figure 15: Safe Operating p-channel

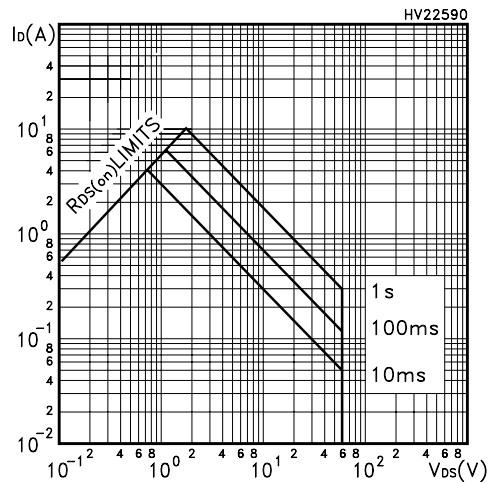


Figure 16: Output Characteristics p-channel

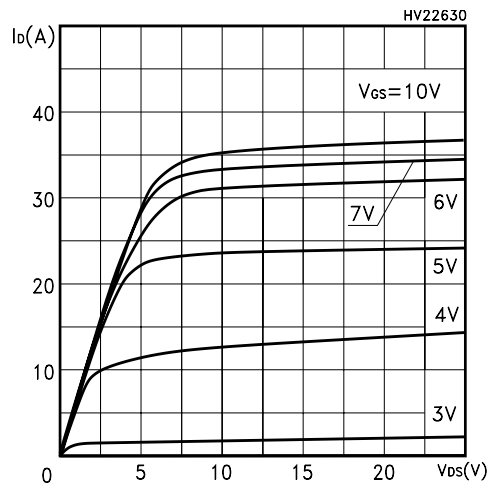


Figure 17: Transconductance p-channel

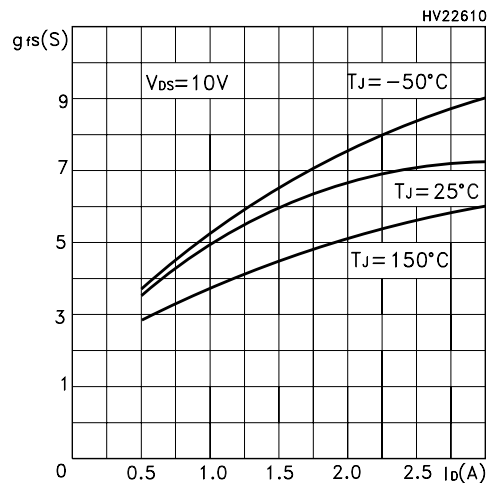


Figure 18: Thermal Impedance for Complementary Pair

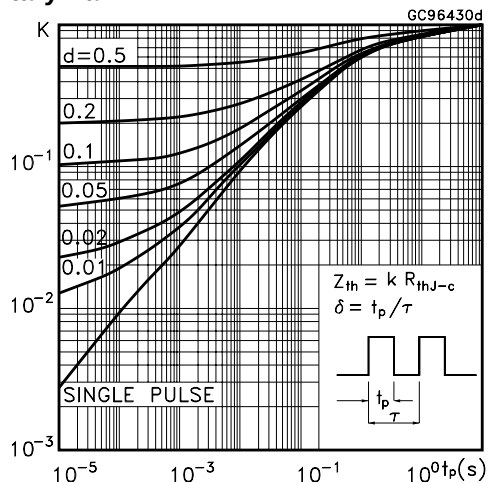


Figure 19: Transfer Characteristics p-channel

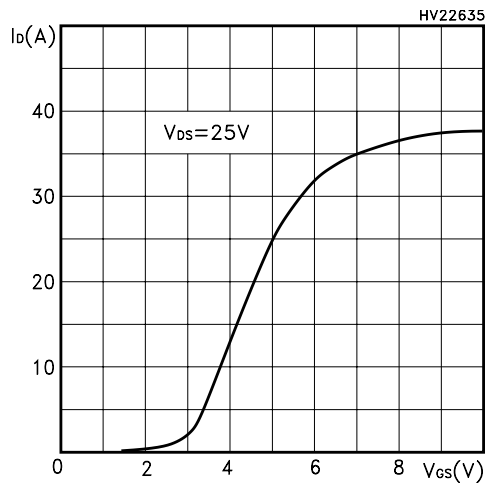


Figure 20: Static Drain-Source On Resistance p-channel

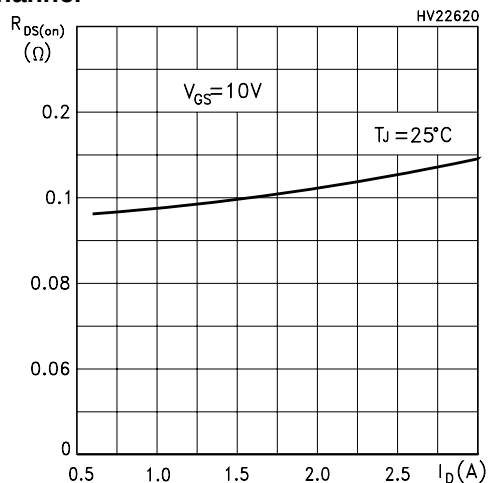


Figure 21: Gate Charge vs Gate-Source Voltage p-channel

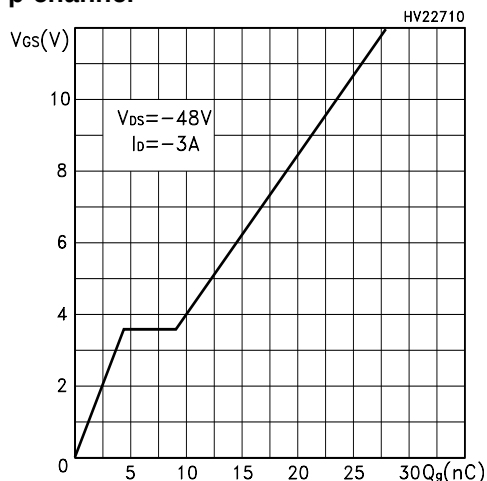


Figure 22: Normalized Gate Threshold Voltage vs Temperature p-channel

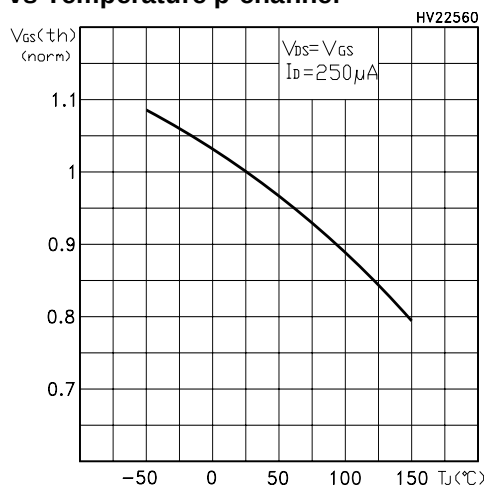


Figure 23: Source-Drain Diode Forward Characteristics p-channel

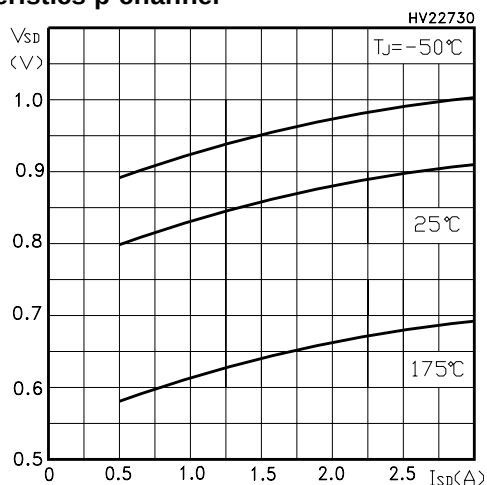


Figure 24: Capacitances Variations p-channel

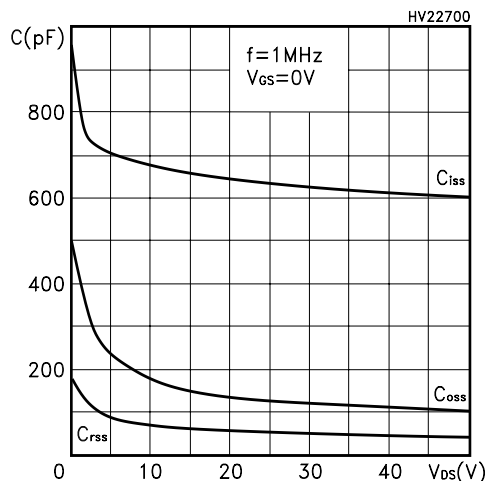


Figure 25: Normalized On Resistance vs Temperature p-channel

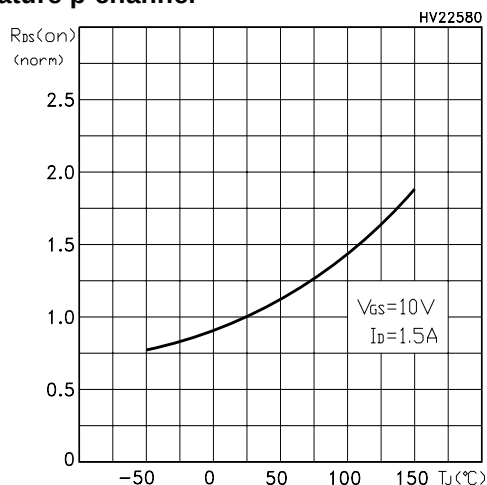


Figure 26: Normalized BVdss vs Temperature p-channel

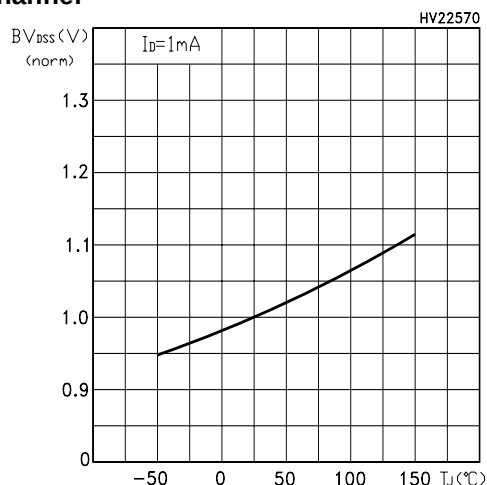


Figure 27: Unclamped Inductive Load Test Circuit

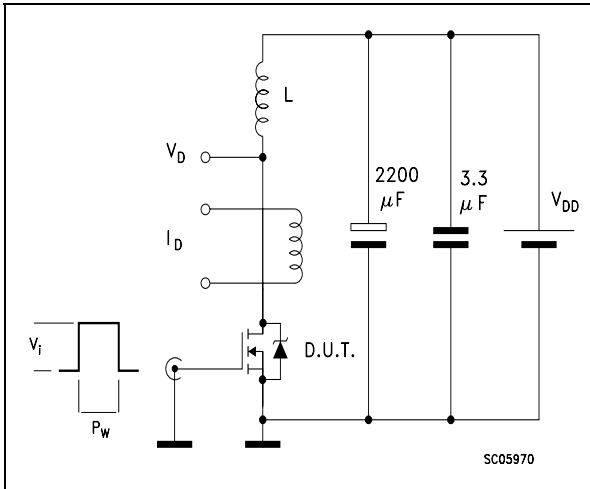


Figure 28: Switching Times Test Circuit For Resistive Load

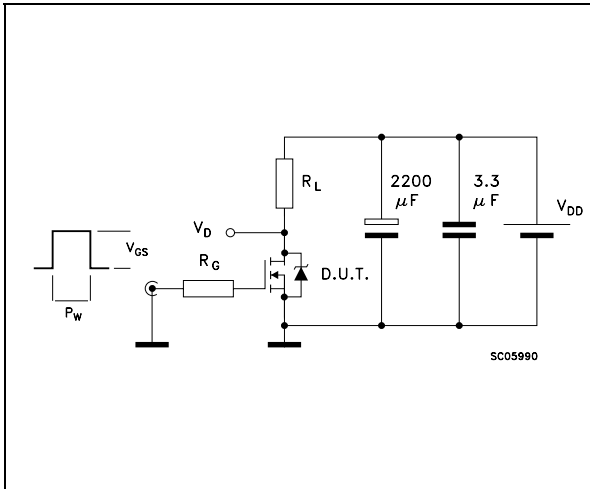


Figure 29: Test Circuit For Inductive Load Switching and Diode Recovery Times

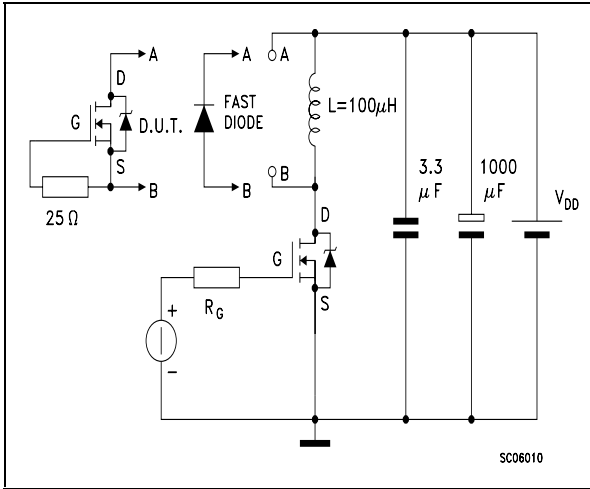


Figure 30: Unclamped Inductive Wavform

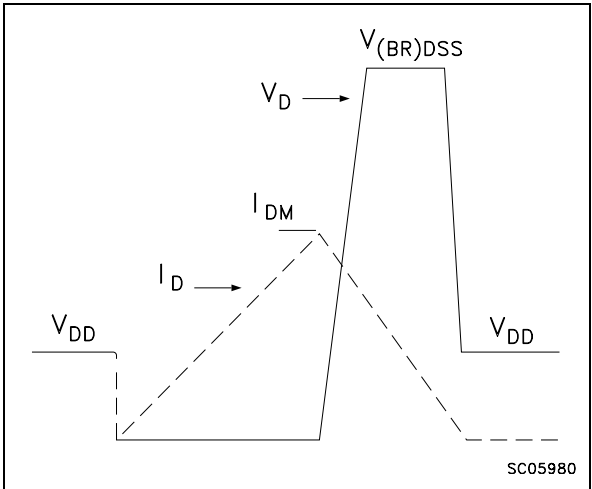
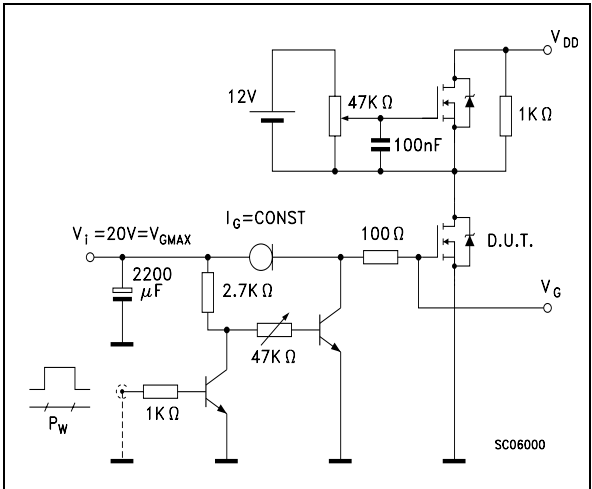


Figure 31: Gate Charge Test Circuit



SO-8 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
C	0.25		0.5	0.010		0.019
c1	45 (typ.)					
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
M			0.6			0.023
S	8 (max.)					

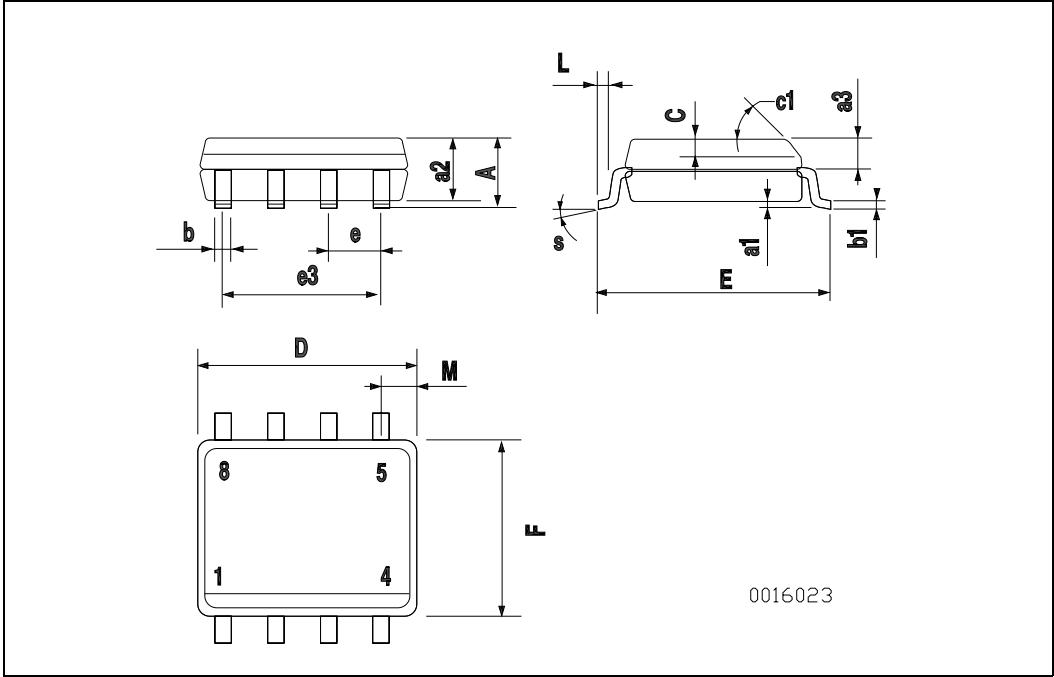


Table 10: Revision History

Date	Revision	Description of Changes
16-Sep-2004	2	Complete Version

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